# **Power MOSFET**

# 60 V, 7.1 m $\Omega$ , 82 A, Single N-Channel

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- High Current Capability
- Avalanche Energy Specified
- AEC-Q101 Qualified
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	60	٧
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain Cur-		T <sub>C</sub> = 25°C	I <sub>D</sub>	82	Α
rent R <sub>θJC</sub> (Note 1)	Steady	T <sub>C</sub> = 100°C		58	
Power Dissipation R <sub>θJC</sub>	State	T <sub>C</sub> = 25°C	$P_{D}$	96	W
(Note 1)		T <sub>C</sub> = 100°C		48	
Continuous Drain Cur-		T <sub>A</sub> = 25°C	I <sub>D</sub>	14.9	Α
rent R <sub>θJA</sub> (Notes 1 & 2)	Steady	T <sub>A</sub> = 100°C		11.5	
Power Dissipation R <sub>θJA</sub>	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	3.1	W
(Notes 1 & 2)		T <sub>A</sub> = 100°C		1.6	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	500	Α
Current Limited by Package (Note 3)	T <sub>A</sub> = 25°C		I <sub>Dmaxpkg</sub>	60	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to 175	°C
Source Current (Body Diode)			I <sub>S</sub>	82	Α
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 50 V, V <sub>GS</sub> = 10 V, $I_{L(pk)}$ = 23 A, L = 1.0 mH, $I_{RG}$ = 25 $I_{L(pk)}$			E <sub>AS</sub>	265	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain)	$R_{\theta JC}$	1.6	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	48	

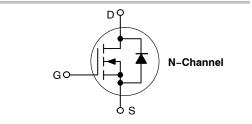
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Continuous DC current rating. Maximum current for pulses as long as 1 second are higher but are dependent on pulse duration and duty cycle.



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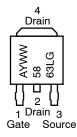
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>	
60 V	7.1 mΩ @ 10 V	82 A	
	9.0 m $\Omega$ @ 4.5 V	02 A	





DPAK CASE 369AA STYLE 2

# MARKING DIAGRAMS & PIN ASSIGNMENT



A = Assembly Location\*

Y = Year WW = Work Week 5863L = Device Code G = Pb-Free Package

\* The Assembly Location Code (A) is front side optional. In cases where the Assembly Location is stamped in the package bottom (molding ejecter pin), the front side assembly code may be blank.

#### **ORDERING INFORMATION**

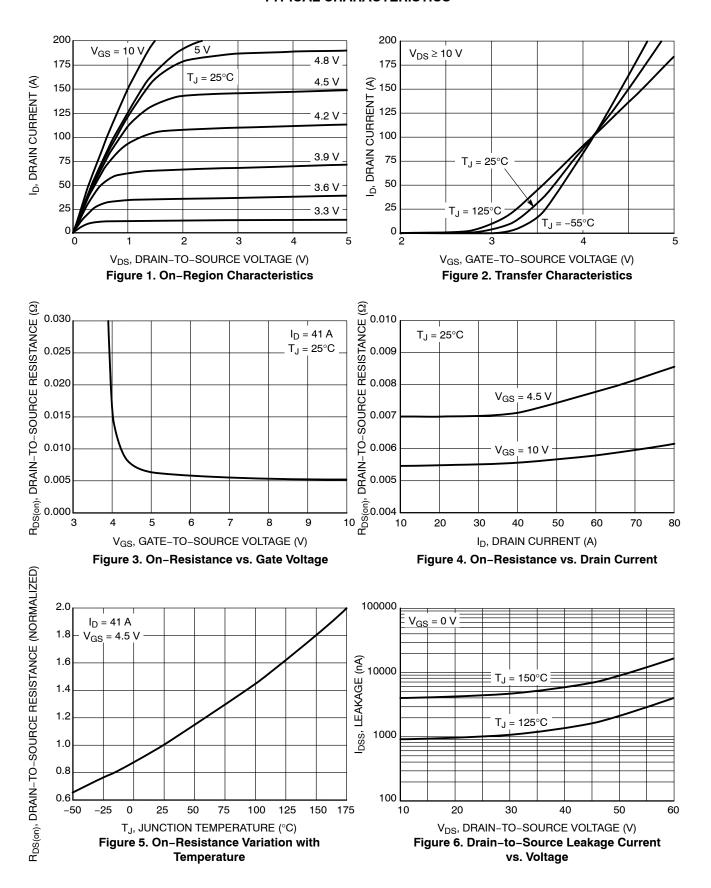
See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	· · · · ·				-	-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				50		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V.	T <sub>J</sub> = 25°C			1.0	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = 48 \text{ V}$ $T_{J} = 1$	T <sub>J</sub> = 150°C			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	<sub>S</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)					•	•	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.0		3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				6.7		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I	<sub>O</sub> = 41 A		5.6	7.1	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 41 A			7.2	9.0	
CHARGES, CAPACITANCES AND GA	TE RESISTANCE	:S				•	•
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 25 \text{ V}$			3850		pF
Output Capacitance	C <sub>oss</sub>				350		1
Reverse Transfer Capacitance	C <sub>rss</sub>				220		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 48 V, I <sub>D</sub> = 41 A			36		nC
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 48 V, I <sub>D</sub> = 41 A			70		
Threshold Gate Charge	Q <sub>G(TH)</sub>				3.7		
Gate-to-Source Charge	$Q_{GS}$				12.3		
Gate-to-Drain Charge	$Q_{GD}$				19.4		
SWITCHING CHARACTERISTICS (Not	e 5)				•	•	
Turn-On Delay Time	t <sub>d(on)</sub>				12.8		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V. V <sub>r</sub>	nn = 48 V.		24.4		
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ = 10 V, $V_{DD}$ = 48 V, $I_{D}$ = 41 A, $R_{G}$ = 2.5 $\Omega$			37.6		
Fall Time	t <sub>f</sub>				55		
DRAIN-SOURCE DIODE CHARACTER	RISTICS				•	•	
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.88	1.2	V
		I <sub>S</sub> = 41 A	T <sub>J</sub> = 150°C		0.73		1
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs, I <sub>S</sub> = 41 A			31		ns
Charge Time	ta				18		1
Discharge Time	tb				13		1
Reverse Recovery Charge	Q <sub>RR</sub>				31		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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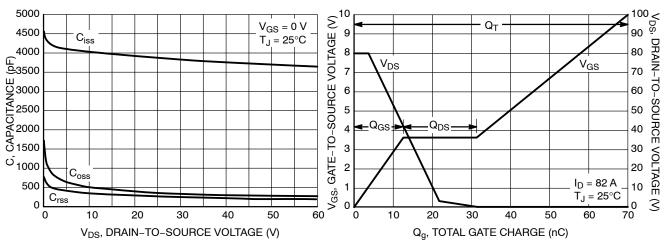


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source & Drain-to-Source vs. Total Charge

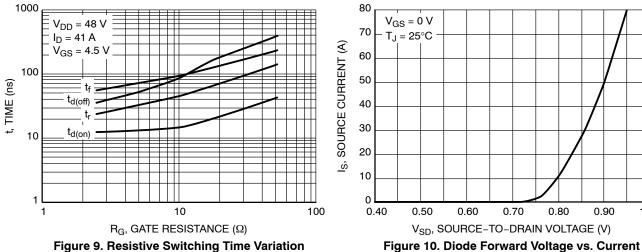


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

1000

100

0.1

0.1

V<sub>GS</sub> = 10 V

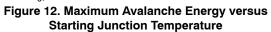
T<sub>C</sub> = 25°C

ID, DRAIN CURRENT (A)

300 I<sub>D</sub> = 23 A 250 200 150 100 50 O 25 100 125 150 175

1.00

Figure 11. Maximum Rated Forward Biased Safe Operating Area



# **TYPICAL CHARACTERISTICS**

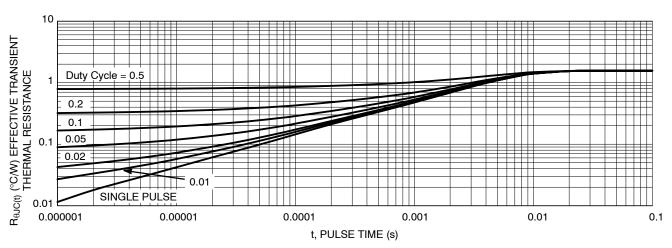


Figure 13. Thermal Response

# **ORDERING INFORMATION**

Order Number	Package	Shipping <sup>†</sup>
NVD5863NLT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD5863NLT4G-VF01	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

STYLE 1: PIN 1. BASE

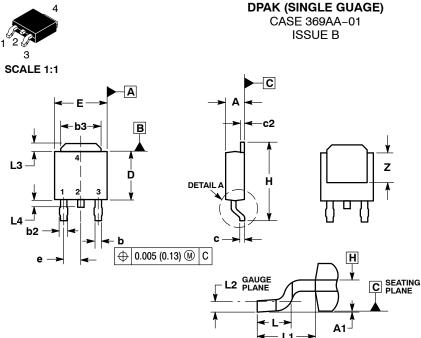
STYLE 5:

2. COLLECTOR 3. EMITTER

4. COLLECTOR

PIN 1. GATE 2. ANODE 3. CATHODE

4. ANODE



STYLE 3: PIN 1. ANODE

STYLE 7:

2. CATHODE 3. ANODE

PIN 1. GATE 2. COLLECTOR

3. EMITTER

COLLECTOR

CATHODE

**DETAIL A** ROTATED 90° CW

STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE



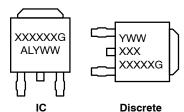
**DATE 03 JUN 2010** 

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090 BSC		2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108 REF		2.74 REF		
L2	0.020 BSC		0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

## **GENERIC** MARKING DIAGRAM\*



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

# **SOLDERING FOOTPRINT\***

3. GATE

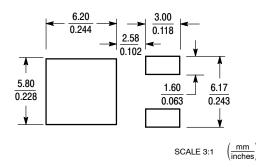
STYLE 2: PIN 1. GATE

STYLE 6:

PIN 1. MT1 2. MT2

2. DRAIN 3. SOURCE

4. DRAIN



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1	

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